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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/717,406	11/19/2003	Charles Q. Zhan	120 06741US	7240
128	7590	11/10/2004	EXAMINER	
HONEYWELL INTERNATIONAL INC.			LE, TOAN M	
101 COLUMBIA ROAD			ART UNIT	
P O BOX 2245			PAPER NUMBER	
MORRISTOWN, NJ 07962-2245			2863	

DATE MAILED: 11/10/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

## Office Action Summary

Application No.

10/717,406

Applicant(s)

ZHAN ET AL.

Examiner

Toan M Le

Art Unit

2863

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

### Status

- 1) ☒ Responsive to communication(s) filed on 19 November 2003.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

### Disposition of Claims

- 4) ☒ Claim(s) 1-22 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-22 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

### Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 19 November 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

### Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
- ☐ Certified copies of the priority documents have been received.
  - ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  - ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.

### Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)  
Paper No(s)/Mail Date \_\_\_\_\_
- 4) ☐ Interview Summary (PTO-413)  
Paper No(s)/Mail Date. \_\_\_\_\_
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: \_\_\_\_\_

## DETAILED ACTION

### *Claim Rejections - 35 USC § 102*

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(a) the invention was known or used by others in this country, or patented or described in a printed publication in this or a foreign country, before the invention thereof by the applicant for a patent.

Claims 1-2, 4-5, 7-9, 11, 14-16, and 18 are rejected under 35 U.S.C. 102(a) as being anticipated by “Applying MultiResolution Analysis for Processing of Hydraulic Pump Fault Signal”, Wanlu et al. (referred hereafter Wanlu et al.).

Referring to claims 1, 8, and 15, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code (Abstract); comprising:

decomposing a signal comprising a plurality of process variable measurements into a plurality of resolution levels, the process variable measurements associated with operation of a valve (page 2, 2<sup>nd</sup> col., lines 19-37; figure 1);

grouping the resolution levels into a plurality of groups; and identifying one or more defect indicators for at least some of the resolution levels using the groups, the one or more defect indicators associated with a possible defect in the valve (page 3, 2<sup>nd</sup> col., last paragraph).

identifying one or more defect indicators for at least some of the resolution levels using the groups, the one or more defect indicators associated with a possible defect in the valve (page 4, 1<sup>st</sup> col., last paragraph, 2<sup>nd</sup> col., 1<sup>st</sup> and last paragraphs; figure 2).

As to claims 2, 9, and 16, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein:

decomposing the signal comprises performing wavelet decomposition to generate wavelet coefficients at each of the resolution levels (page 3, 2<sup>nd</sup> col., last paragraph; table 1);

grouping the resolution levels comprises grouping the wavelet coefficients into groups (page 2, 2<sup>nd</sup> col., last paragraph; table 1); and

identifying the one or more defect indicators comprises performing singularity detection using the groups of wavelet coefficients (page 4, 1<sup>st</sup> col., last paragraph, 2<sup>nd</sup> col., 1<sup>st</sup> and last paragraphs; figure 2).

Referring to claims 4, 11, and 18, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein the one or more defect indicators identify one or more jumps in the process variable measurements (page 4, 2<sup>nd</sup> col., last paragraph; figure 2).

As to claim 5, Wanlu et al. disclose a method, wherein the one or more jumps represent one or more deterministic signal changes where the process variable measurements change by a threshold amount within a given time period (page 4, 2<sup>nd</sup> col., last paragraph; figure 2).

Referring to claims 7 and 14, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein grouping the resolution levels into the plurality of groups comprises grouping the adjacent three resolution

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levels into groups, the groups forming overlapping groups where at least some of the resolution levels form part of two or more groups (page 4, 2<sup>nd</sup> col., 1<sup>st</sup> paragraph; figure 2).

Claims 3, 6, 10, 12-13, 17, 19-20 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The reason for allowance of the claims 3, 6, 10, 12-13, 17, 19-20 is the inclusion of steps of determining a probability of a valve defect based on the selected resolution level from measurements of a flow rate through the valve and generating a second signal for a valve adjuster.

Wanlu et al. neither teach nor suggest those limitations.

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 21-22 are rejected under 35 U.S.C. 102(b) as being anticipated by “WPT-SVMs Based Approach for Fault Detection of Valves in Reciprocating Pumps”, He et al. (referred hereafter He et al.).

Referring to claim 21, He et al. disclose a system, comprising:

a valve;

a measuring device operable to generate a signal comprising measurements of a process variable associated with operation of the valve (page 4568, 2<sup>nd</sup> col., last paragraph);

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a controller operable to generate output values for adjusting the valve based on the process variable measurements (page 4568, 2<sup>nd</sup> col., last paragraph); and

a defect detector operable to:

decompose the signal into a plurality of resolution levels;

group the resolution levels into a plurality of groups; and

identify one or more defect indicators for at least some of the resolution levels using the groups, the one or more defect indicators associated with a possible defect in the valve (page 4569, 1<sup>st</sup> col., 1<sup>st</sup> and 2<sup>nd</sup> paragraphs; figure 3).

As to claim 22, He et al. disclose a system, wherein the defect detector forms part of the controller (table 1).

### *Conclusion*

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

U.S. Patent No. 5,966,674 to Crawford et al.    U.S. Patent No. 6,539,315 to Adams et al.

U.S. Patent No. 6,208,943 to Randolph et al.    U.S. Patent No. 5,641,891 to Frankl et al.

U.S. Patent No. 6,725,167 to Grumstrup et al.    U.S. Patent No. 6,654,697 to Eryurek et al.

U.S. Patent No. 6,408,676 to Stratton et al.    U.S. Patent No. 6, 505,517 to Eryurek et al.

U.S. Patent No. 5,646,600 to Abdel-Malek et al.

U.S. Patent No. 5,594,180 to Carpenter et al.    U.S. Patent No. 5,381,697 to van der Pol

“The Fault Character of the Motors Identified Based on Wavelet Transform”, Wang et al., Proceedings of the Second International Conference on Machine Learning and Cybernetics, November 2-5, 2003, Pages 2394-2398

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“Singularity Detection and Processing with Wavelet”, Mallat et al., IEEE Transactions on Information Theory, Vol. 38, No. 2, March 1992, Pages 617-643.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Toan M Le whose telephone number is (571) 272-2276. The examiner can normally be reached on Monday through Friday from 9:00 A.M. to 5:30 P.M..

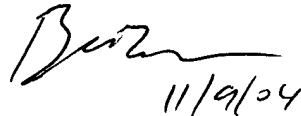
If attempts to reach the examiner by telephone are unsuccessful, the examiner’s supervisor, John Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Toan Le

November 4, 2004

**BRYAN BUI**  
**PRIMARY EXAMINER**



11/9/04